

# 2SD1749, 2SD1749A

## Silicon NPN triple diffusion planar type darlington

For low-frequency power amplification

Complementary to 2SB1179 and 2SB1179A

### ■ Features

- High forward current transfer ratio  $h_{FE}$
- High-speed switching
- I type package enabling direct soldering of the radiating fin to the printed circuit board, etc. of small electronic equipment

### ■ Absolute Maximum Ratings $T_C = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	2SD1749	60	V
	2SD1749A	80	
Collector-emitter voltage (Base open)	2SD1749	60	V
	2SD1749A	80	
Emitter-base voltage (Collector open)	$V_{EBO}$	5	V
Collector current	$I_C$	4	A
Peak collector current	$I_{CP}$	8	A
Collector power dissipation	$P_C$	15	W
		$T_a = 25^\circ\text{C}$	
Junction temperature	$T_j$	150	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-55 to +150	$^\circ\text{C}$

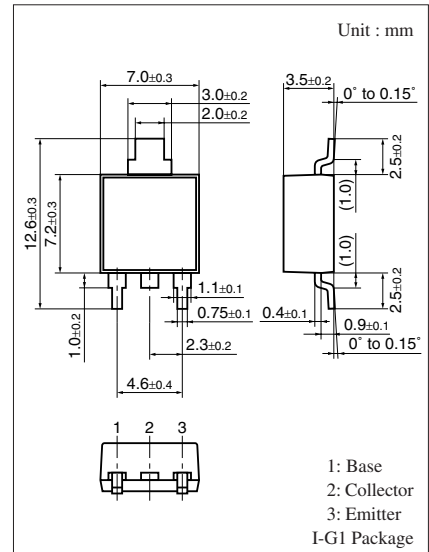
### ■ Electrical Characteristics $T_C = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-emitter voltage (Base open)	2SD1749	$I_C = 30 \text{ mA}, I_B = 0$	60			V
	2SD1749A		80			
Base-emitter voltage	$V_{BE}$	$V_{CE} = 3 \text{ V}, I_C = 3 \text{ A}$			2.5	V
Collector-base cutoff current (Emitter open)	2SB1749	$V_{CB} = 60 \text{ V}, I_E = 0$			200	$\mu\text{A}$
	2SB1749A		$V_{CB} = 80 \text{ V}, I_E = 0$		200	
Collector-emitter cutoff current (Base open)	2SB1749	$V_{CE} = 30 \text{ V}, I_B = 0$			500	$\mu\text{A}$
	2SB1749A		$V_{CE} = 40 \text{ V}, I_B = 0$		500	
Emitter-base cutoff current (Collector open)	$I_{EBO}$	$V_{EB} = 5 \text{ V}, I_C = 0$			2	mA
Forward current transfer ratio	$h_{FE1}$	$V_{CE} = 3 \text{ V}, I_C = 0.5 \text{ A}$	1000			—
	$h_{FE2}^*$	$V_{CE} = 3 \text{ V}, I_C = 3 \text{ A}$	2000		10000	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 3 \text{ A}, I_B = 12 \text{ mA}$			2.0	V
		$I_C = 5 \text{ A}, I_B = 20 \text{ mA}$			4.0	
Forward current transfer ratio	$f_T$	$V_{CE} = 10 \text{ V}, I_C = 0.5 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time	$t_{on}$	$I_C = 3 \text{ A}, I_{B1} = 12 \text{ mA}, I_{B2} = -12 \text{ mA}$		0.5		$\mu\text{s}$
Storage time	$t_{stg}$	$V_{CC} = 50 \text{ V}$		4.0		$\mu\text{s}$
Fall time	$t_f$			1.0		$\mu\text{s}$

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

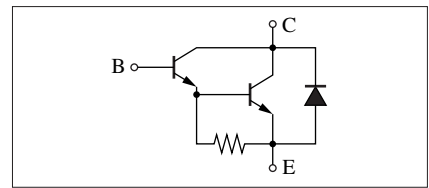
2. \*: Rank classification

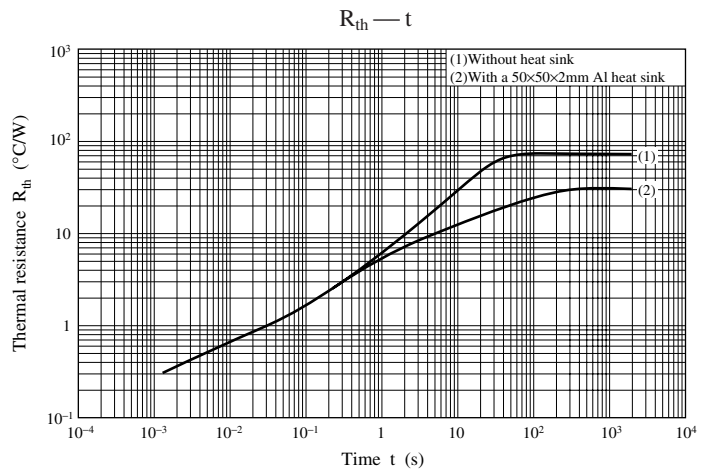
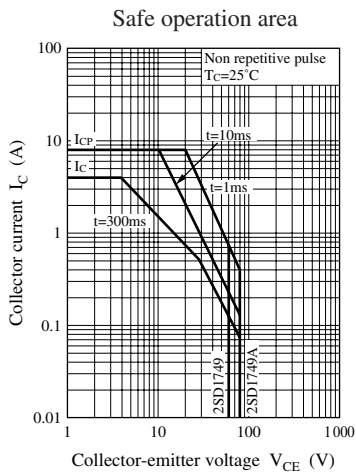
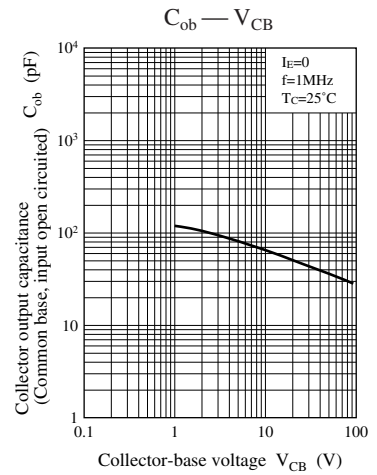
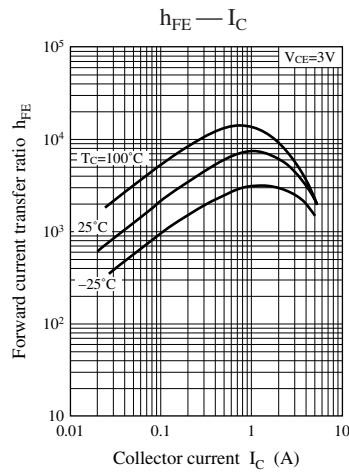
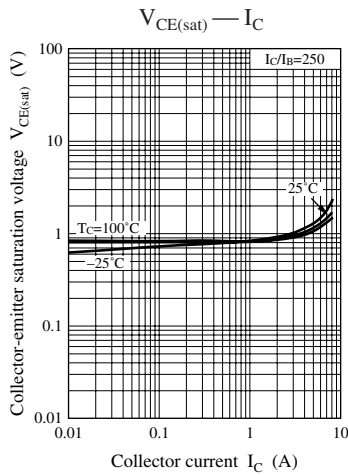
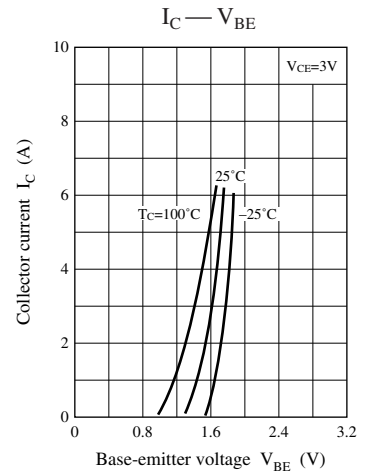
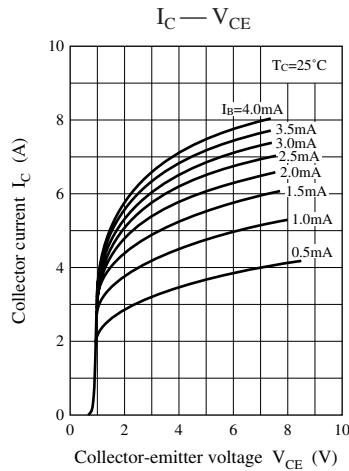
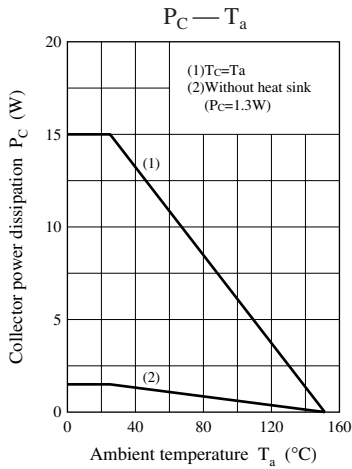
Rank	Q	P
$h_{FE2}$	2000 to 5000	4000 to 10000



Note) Self-supported type package is also prepared.

### Internal Connection





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